

ACPL-M61T

Automotive Wide Operating Temperature AEC-Q100 Compliant 10MBd Digital Optocoupler

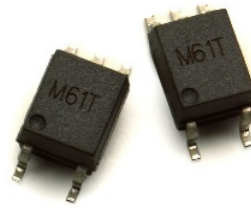


Data Sheet



Lead (Pb) Free
RoHS 6 fully
compliant

RoHS 6 fully compliant options available;
-xxxE denotes a lead-free product



Description

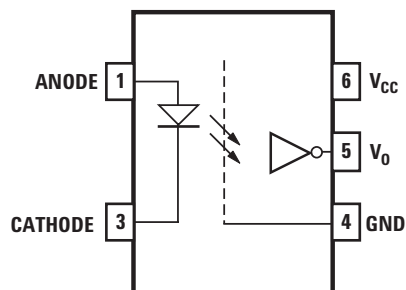
This small outline wide operating temperature, high CMR, high speed, logic gate optocoupler is a single channel device in a five lead miniature footprint.

The ACPL-M61T optically coupled gates combine a AlGaAs light emitting diode and an integrated high gain photo detector. The output of the detector IC is an Open-collector Schottky-clamped transistor. The internal shield provides a guaranteed common mode transient immunity specification of 15,000 V/ μ s at $V_{CM}=1000V$.

This optocoupler is suitable for use in automotive high speed communications logic interfacing with low propagation delays, input/output buffering and is recommended for use in high operating temperature environment.

This unique design provides maximum AC and DC circuit isolation while achieving TTL compatibility. The optocoupler AC and DC operational parameters are guaranteed from -40°C to 125°C.

Functional Diagram



Features

- High Temperature and Reliability CANBus communication interface for Automotive Application.
- 15 kV/ μ s High Common-Mode Rejection at $V_{CM} = 1000V$
- Compact, Auto-Insertable SO5 Packages
- Wide Temperature Range: -40°C ~ 125°C
- High Speed: 10MBd (Typical)
- Low LED Drive Current: 6.5mA (typ)
- Low Propagation Delay: 100ns (max)
- Worldwide Safety Approval:
 - UL 1577, 3750 Vrms/1 min.
 - CSA File CA88324, Notice #5
- Qualified according to AEC-Q100 Test Guidelines

Applications

- Automotive CANBus Communications Interface
- High Temperature Digital Signal Isolation
- Micro-controller Interface
- Digital isolation for A/D, D/A conversion

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

Ordering Information

ACPL-M61T is UL Recognized with 3750 Vrms for 1 minute per UL1577 and is approved under CSA Component Acceptance Notice #5, File CA 88324.

Part number	Option		Package	Surface Mount	Gull Wing	Tape & Reel	UL 5000 Vrms/1 Minute rating	IEC/EN/DIN EN 60747-5-2	Quantity
	RoHS Compliant	Non RoHS Compliant							
ACPL-M61T	-000E	No option	SO-5						100 per tube
	-500E	-500		X	X	X			1500 per reel

To order, choose a part number from the part number column and combine with the desired option from the option column to form an order entry.

Example 1:

ACPL-M61T-500E to order product of Mini-flat Surface Mount 5-pin package in Tape and Reel packaging with RoHS compliant.

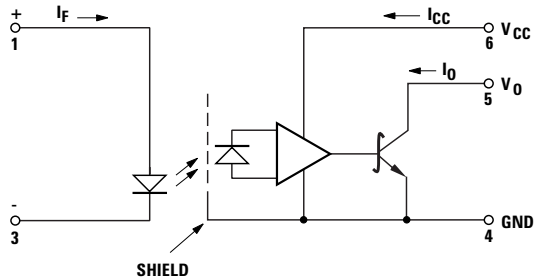
Example 2:

ACPL-M61T to order product of Mini-flat Surface Mount 5-pin package in tube packaging and non RoHS compliant.

Option datasheets are available. Contact your Avago sales representative or authorized distributor for information.

Remarks: The notation '#XXX' is used for existing products, while (new) products launched since 15th July 2001 and RoHS compliant option will use '-XXXE'.

Schematic

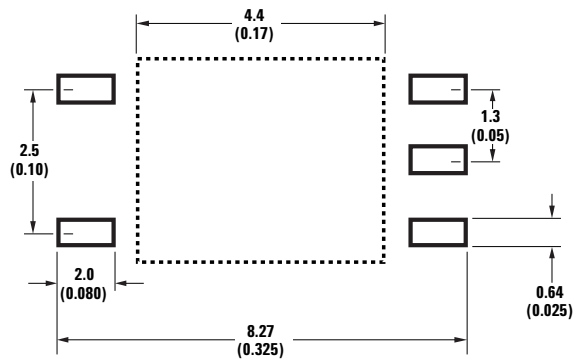


USE OF A 0.1 μ F BYPASS CAPACITOR MUST BE CONNECTED BETWEEN PINS 6 AND 4 (SEE NOTE 1).

TRUTH TABLE (POSITIVE LOGIC)

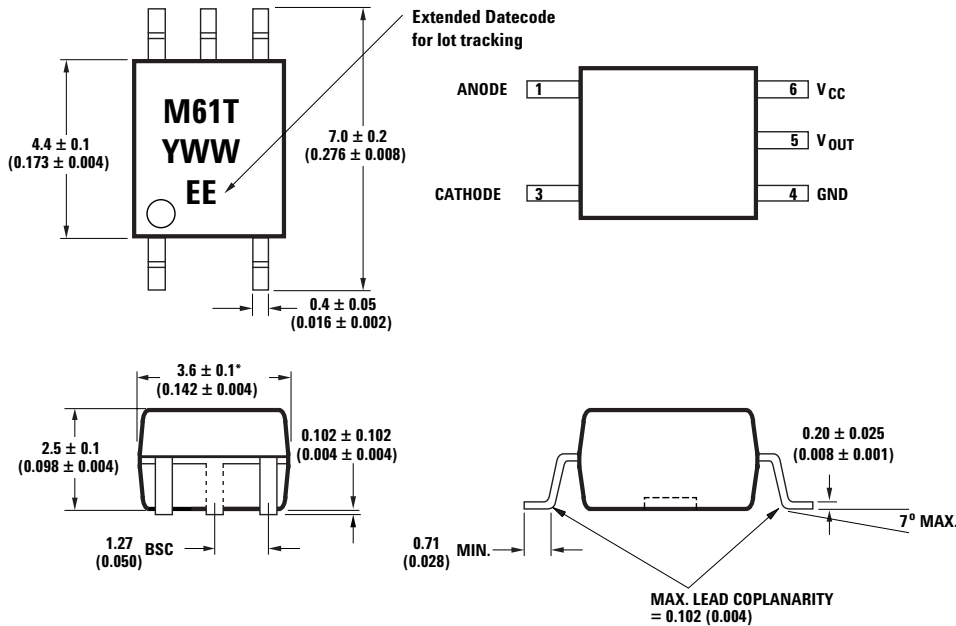
LED	OUTPUT
ON	L
OFF	H

Land Pattern Recommendation



Package Outline Drawings

ACPL-M61T Small Outline SO-5 Package (JEDEC MO-155)

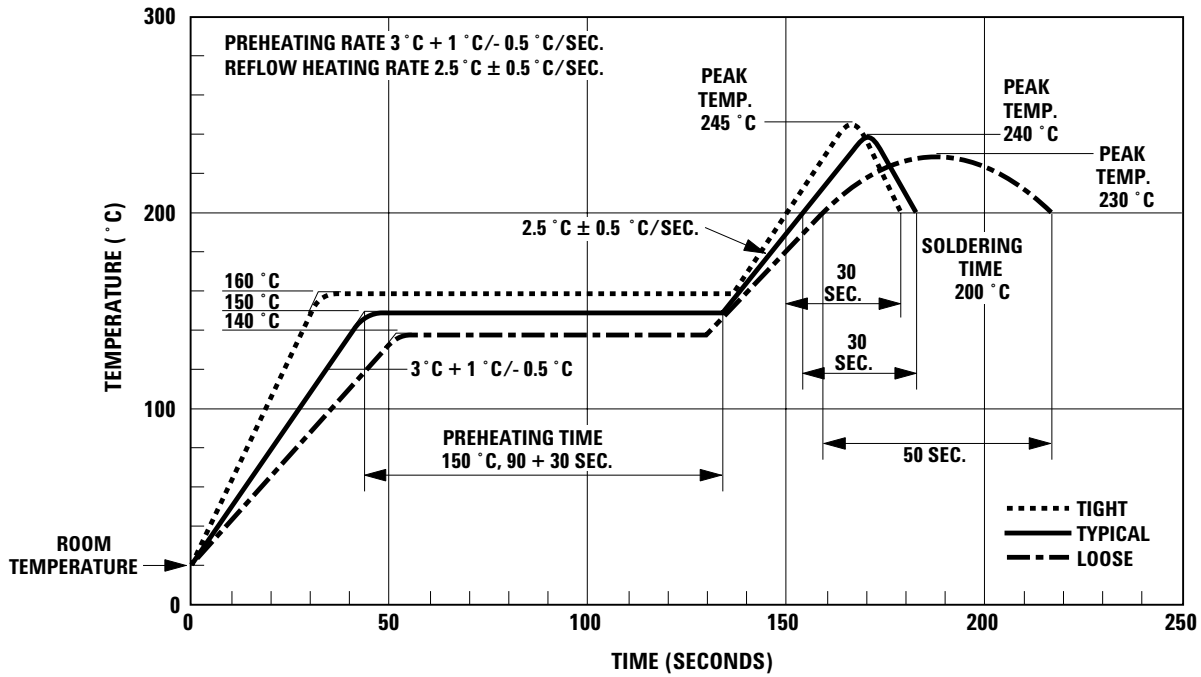


DIMENSIONS IN MILLIMETERS (INCHES)

* MAXIMUM MOLD FLASH ON EACH SIDE IS 0.15 mm (0.006)

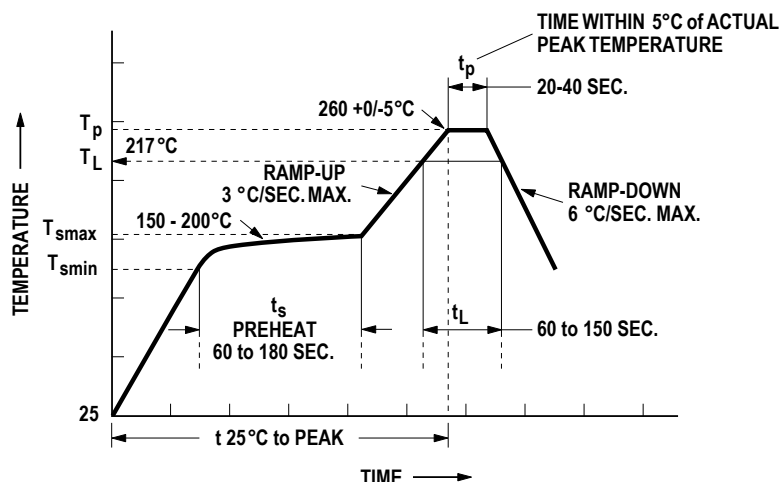
NOTE: FLOATING LEAD PROTRUSION IS 0.15 mm (6 mils) MAX.

Solder Reflow Temperature Profile



Note: Non-halide flux should be used.

Recommended Pb-Free IR Profile



NO TES:

THE TIME FROM 25°C TO PEAK TEMPERATURE = 8 MINUTES MAX.

$T_{smax} = 200^{\circ}\text{C}$, $T_{smin} = 150^{\circ}\text{C}$

Note: Non-halide flux should be used.

Regulatory Information

The ACPL-M61T is pending approval by the following organizations:

UL

Approved under UL 1577, component recognition program up to $V_{ISO} = 3750 V_{RMS}$ expected prior to product release.

CSA

Approved under CSA Component Acceptance Notice #5.

Insulation and Safety Related Specifications

Parameter	Symbol	ACPL-M61T	Units	Conditions
Minimum External Air Gap (Clearance)	L(101)	≥ 5	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (Creepage)	L(102)	≥ 5	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	mm	Through insulation distance conductor to conductor, usually the straight line distance thickness between the emitter and detector.
Tracking Resistance (Comparative Tracking Index)	CTI	175	V	DIN IEC 112/VDE 0303 Part 1
Isolation Group (DIN VDE0109)		IIIa		Material Group (DIN VDE 0109)

Absolute Maximum Ratings

Parameter	Symbol	Min.	Max.	Units	Note
Storage Temperature	T_S	-55	125	°C	
Operating Temperature	T_A	-40	125	°C	
Lead Soldering Cycle	Temperature		260	°C	
	Time		10	sec	
Input Current (50% duty cycle, 1ms pulse width) ($\leq 1\mu\text{s}$ pulse width, 300ps)	Average	$I_{F(\text{avg})}$	20	mA	12
	Peak	$I_{F(\text{peak})}$	40	mA	
	Transient	$I_{F(\text{trans})}$	100	mA	
Reversed Input Voltage	V_R		5	V	
Input Power Dissipation	P_I		30	mW	13
Output Power Dissipation	P_O		85	mW	14
Output Collector Current	I_O		50	mA	
Supply Voltage (Pins 6-4)	V_{CC}	-0.5	7	V	
Output Voltage (Pins 5-4)	V_O	-0.5	7	V	

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units
Supply Voltage	V_{CC}	4.5	5.5	V
Operating Temperature	T_A	-40	125	°C
Input Current, Low Level	I_{FL}^*	0	250	μA
Input Current, High Level	I_{FH}	5	15	mA
Fan Out ($R_L = 1\text{k}\Omega$)	N		5	TTL Loads
Output Pull-Up Resistor	R_L	330	4,000	Ω

*The off condition can also be guaranteed by ensuring that $V_{F(\text{off})} \leq 0.8\text{Volts}$

Electrical Specifications (DC)

Over recommended operating Temperature $T_A = -40^\circ\text{C}$ to 125°C , unless otherwise specified.

Parameter	Symbol	Min.	Typ.*	Max.	Units	Conditions	Fig.	Note
Input Threshold Current	I_{TH}		2	5	mA	$V_{CC} = 5.5\text{V}$, $I_O \geq 13\text{mA}$, $V_O = 0.6\text{V}$	4	
High Level Output Current	I_{OH}		5.5	100	μA	$V_{CC} = 5.5\text{V}$, $V_O = 5.5\text{V}$, $V_F = 0.5\text{V}$	1	
Low Level Output Voltage	V_{OL}		0.4	0.6	V	$V_{CC} = 5.5\text{V}$, $I_F = 6.5\text{mA}$ $I_{OL}(\text{Sinking}) = 13\text{mA}$	2, 4, 5	
High Level Supply Current	I_{CCH}		7.0	10.0	mA	$V_{CC} = 5.5\text{V}$, $I_F = 0\text{mA}$		
Low Level Supply Current	I_{CCL}		9.0	13.0	mA	$V_{CC} = 5.5\text{V}$, $I_F = 10\text{mA}$,		
Input Forward Voltage	V_F	1.45	1.5	1.85	V	$T_A = 25^\circ\text{C}$, $I_F = 10\text{mA}$		
		1.35	1.5	1.95	V	$I_F = 10\text{mA}$		
Input Reversed Breakdown Voltage	BV_R	5			V	$I_R = 10\mu\text{A}$		
Temperature Coefficient of Forward Voltage	$\Delta V_F / \Delta T_A$		-1.5		mV/°C	$I_F = 10\text{mA}$	3, 12	

*All Typicals at $T_A = 25^\circ\text{C}$, $V_{CC} = 5\text{V}$.

Package Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Momentary Withstand Voltage*	V_{ISO}	3750			V_{rms}	$RH \leq 50\%$, $t = 1 \text{ min}$; $T_A = 25^\circ\text{C}$		
Input-Output Resistance	R_{I-O}		10^{12}		Ω	$V_{I-O} = 500 \text{ Vdc}$		
Input-Output Capacitance	C_{I-O}		0.6		pF	$f = 1 \text{ MHz}$; $V_{I-O} = 0 \text{ Vdc}$		

* The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table (if applicable), your equipment level safety specification, or Avago Technologies Application Note 1074, "Optocoupler Input-Output Endurance Voltage."

Switching Specifications (AC)

Over recommended temperature $T_A = -40^\circ\text{C}$ to 125°C , $V_{CC} = 5.0 \text{ V}$, $I_F = 6.5 \text{ mA}$ unless Otherwise Specified.

Parameter	Symbol	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to Low Output Level	t_{PHL}	46	75	ns	$T_A = 25^\circ\text{C}$	$R_L = 350\Omega$ $C_L = 15\text{pF}$ $I_F = 6.5\text{mA}$	6, 7, 8	6
			100	ns				
Propagation Delay Time to High Output Level	t_{PLH}	50	75	ns	$T_A = 25^\circ\text{C}$		6, 7, 8	5
			100	ns				
Propagation Delay Skew	t_{PSK}		40	ns			14, 15	10, 11
Pulse Width Distortion	$ t_{PHL} - t_{PLH} $	3.5	35	ns			9	10
Output Rise Time (10% - 90%)	t_{rise}		24	ns			10	
Output Fall Time (10% - 90%)	t_{fall}		10	ns			10	
Common Mode Transient Immunity at High Output Level	$ CM_H $	15	30		$\text{kV}/\mu\text{s}$	$V_{CM} = 1000\text{Vp-p}$ $V_o(\text{min}) = 2\text{V}$ $I_F = 0\text{mA}$ $T_A = 25^\circ\text{C}$ $R_L = 350\Omega$	11	7, 9
Common Mode Transient Immunity at Low Output Level	$ CM_L $	15	30		$\text{kV}/\mu\text{s}$	$V_{CM} = 1000\text{Vp-p}$ $V_o(\text{max}) = 0.8\text{V}$ $I_F = 6.5\text{mA}$ $T_A = 25^\circ\text{C}$ $R_L = 350\Omega$		8, 9

*All Typical at $T_A = 25^\circ\text{C}$, $V_{CC} = 5\text{V}$.

Notes:

- By-passing of the power supply line is required with a 0.1 μF ceramic disc capacitor adjacent to each optocoupler. The total lead length between both ends of the capacitor and the isolator pins should not exceed 10 mm.
- Peaking circuits may produce transient input currents up to 40 mA, 50 ns maximum pulse width, provided average current does not exceed 20 mA.
- Device considered a two terminal device: pins 1 and 3 shorted together and pins 4, 5 and 6 shorted together.
- In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage $\geq 4500 V_{RMS}$ for 1 second (Leakage detection current limit, $I_{I-O} \leq 5 \mu\text{A}$).
- The t_{PLH} propagation delay is measured from 3.25 mA point on the falling edge of the input pulse to the 1.5 V point on the rising edge of the output pulse.
- The t_{PHL} propagation delay is measured from 3.25 mA point on the rising edge of the input pulse to the 1.5 V point on the falling edge of the output pulse.
- CM_H is the maximum tolerable rate of rise of the common mode voltage to assure that the output will remain in a high logic state (i.e., $V_{OUT} > 2.0\text{V}$).
- CM_L is the maximum tolerable rate of fall of the common mode voltage to assure that the output will remain in a low logic state (i.e., $V_{OUT} < 0.8\text{V}$).
- For sinusoidal voltages, $(|dV_{CM}|/dt)_{max} = \pi f_{CM} V_{CM(p-p)}$.
- See application section; "Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew" for more information.
- t_{PSK} is equal to the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between units at any given temperature within the worst case operating condition range.
- Input current derates linearly above 85°C free-air temperature at a rate of $0.25 \text{ mA}/^\circ\text{C}$.
- Input power derates linearly above 85°C free-air temperature at a rate of $0.375 \text{ mW}/^\circ\text{C}$.
- Output power derates linearly above 85°C free-air temperature at a rate of $0.475 \text{ mW}/^\circ\text{C}$.

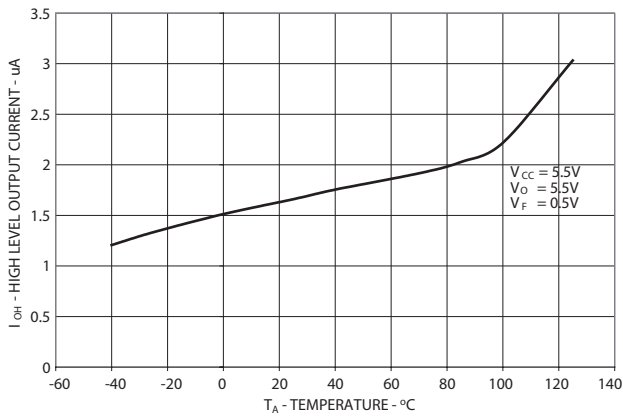


Figure 1. High Level Output Current vs Temperature

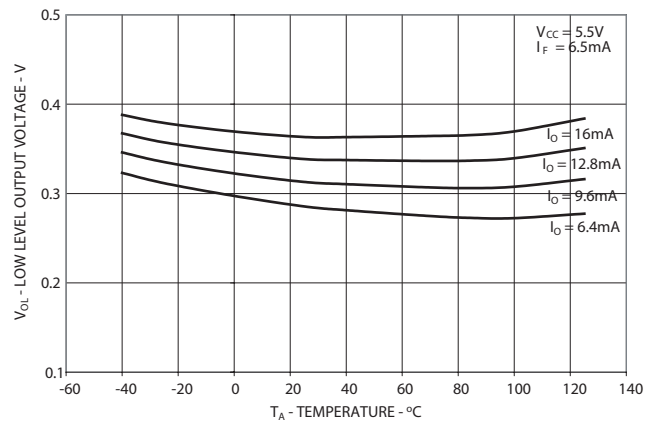


Figure 2. Low Level Output Voltage vs. Temperature

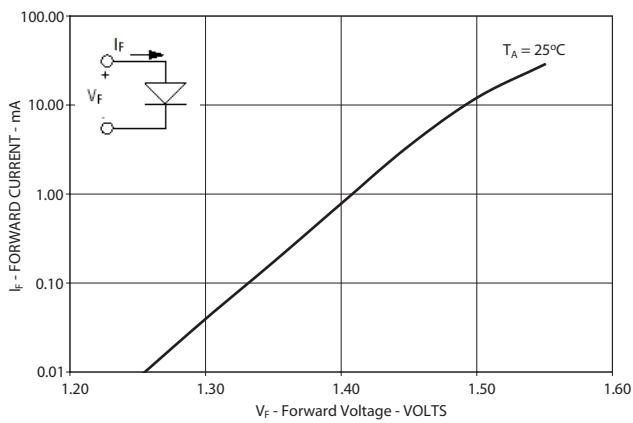


Figure 3. Input Current vs Forward Voltage

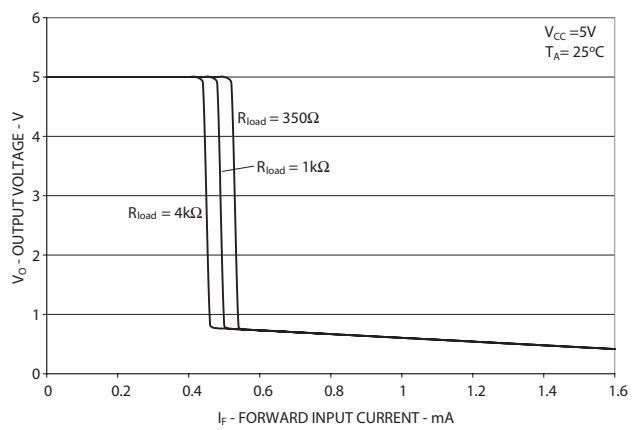


Figure 4. Output Voltage vs Forward Input current

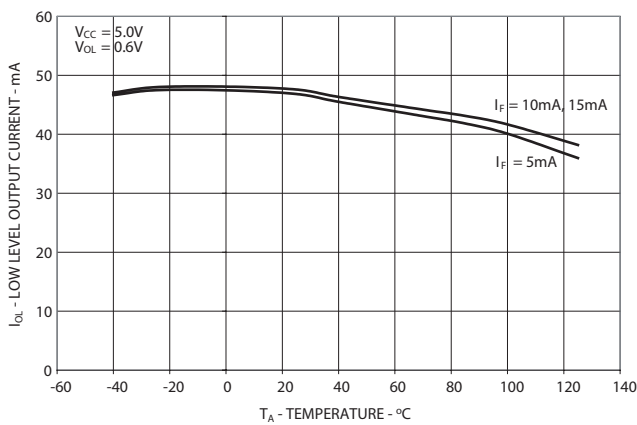


Figure 5. Low Level Output Current vs. Temperature

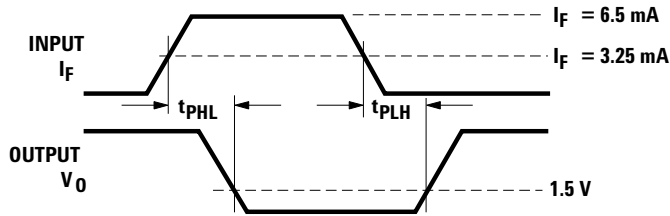
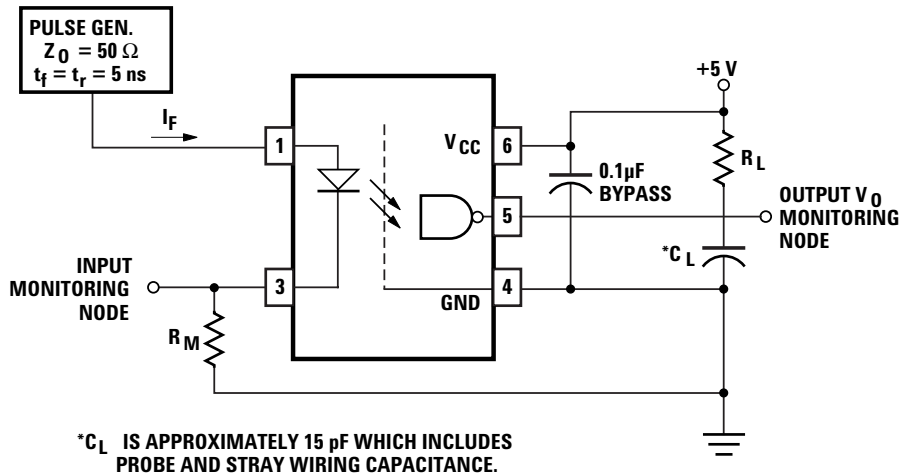


Figure 6. Test Circuit for t_{PHL} and t_{PLH}

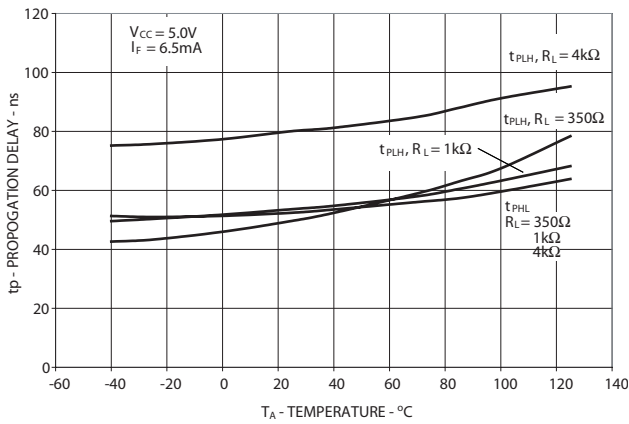


Figure 7. Propagation Delay vs. Temperature

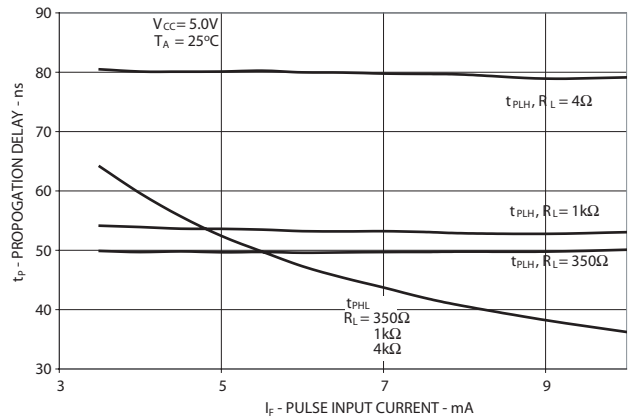


Figure 8. Propagation Delay vs. Pulse Input Current

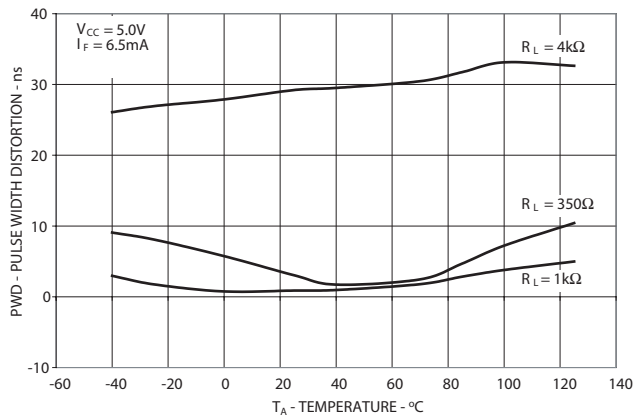


Figure 9. Pulse Width Distortion vs Temperature

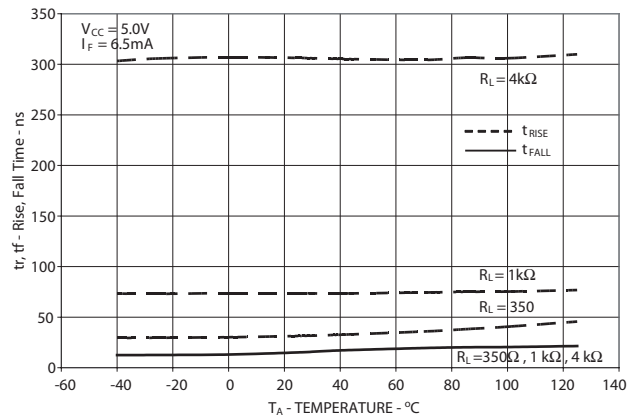


Figure 10. Rise and Fall Time vs Temperature

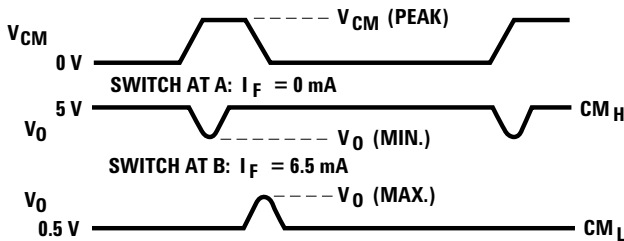
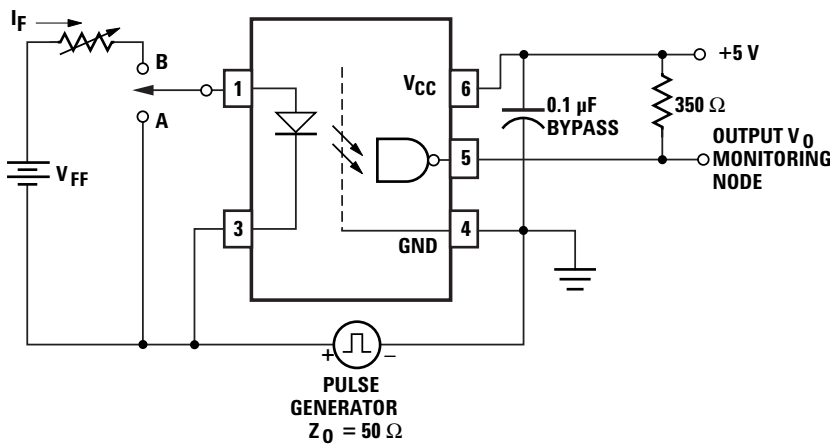


Figure 11. Test Circuit for Common Mode Transient Immunity and Typical Waveforms

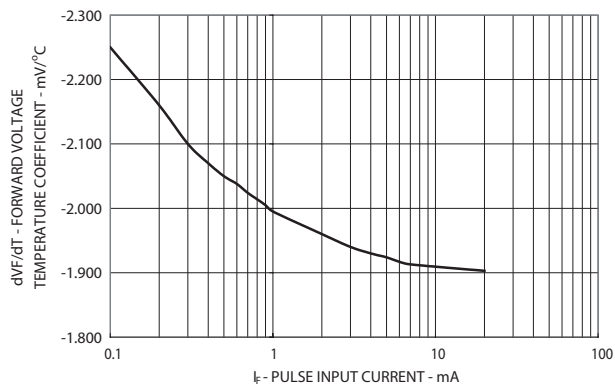


Figure 12. Temperature Coefficient for Forward Voltage vs. Input Current

Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew

Propagation delay is a figure of merit which describes how quickly a logic signal propagates through a system. The propagation delay from low to high (t_{PLH}) is the amount of time required for an input signal to propagate to the output, causing the output to change from low to high. Similarly, the propagation delay from high to low (t_{PHL}) is the amount of time required for the input signal to propagate to the output, causing the output to change from high to low (see Figure 6).

Pulse-width distortion (PWD) results when t_{PLH} and t_{PHL} differ in value. PWD is defined as the difference between t_{PLH} and t_{PHL} and often determines the maximum data rate capability of a transmission system. PWD can be expressed in percent by dividing the PWD (in ns) by the minimum pulse width (in ns) being transmitted. Typically, PWD on the order of 20-30% of the minimum pulse width is tolerable; the exact figure depends on the particular application (RS232, RS422, T-1, etc.).

Propagation delay skew, t_{PSK} , is an important parameter to consider in parallel data applications where synchronization of signals on parallel data lines is a concern. If the parallel data is being sent through a group of optocouplers, differences in propagation delays will cause the data to arrive at the outputs of the optocouplers at different times. If this difference in propagation delays is large enough, it will determine the maximum rate at which parallel data can be sent through the optocouplers.

Propagation delay skew is defined as the difference between the minimum and maximum propagation delays, either t_{PLH} or t_{PHL} , for any given group of optocouplers which are operating under the same conditions (i.e., the same drive current, supply voltage, output load, and operating temperature). As illustrated in Figure 14, if the inputs of a group of optocouplers are switched either ON or OFF at the same time, t_{PSK} is the difference between the shortest propagation delay, either t_{PLH} or t_{PHL} , and the longest propagation delay, either t_{PLH} or t_{PHL} .

As mentioned earlier, t_{PSK} can determine the maximum parallel data transmission rate. Figure 15 is the timing diagram of a typical parallel data application with both the clock and the data lines being sent through optocouplers. The figure shows data and clock signals at the inputs and outputs of the optocouplers. To obtain the maximum data transmission rate, both edges of the clock signal are being used to clock the data; if only one edge were used, the clock signal would need to be twice as fast.

Propagation delay skew represents the uncertainty of where an edge might be after being sent through an optocoupler. Figure 15 shows that there will be uncertainty in both the data and the clock lines. It is important that these two areas of uncertainty not overlap, otherwise the clock signal might arrive before all of the data outputs have settled, or some of the data outputs may start to change before the clock signal has arrived. From these considerations, the absolute minimum pulse width that can be sent through optocouplers in a parallel application is twice t_{PSK} . A cautious design should use a slightly longer pulse width to ensure that any additional uncertainty in the rest of the circuit does not cause a problem.

The t_{PSK} specified optocouplers offer the advantages of guaranteed specifications for propagation delays, pulse-width distortion and propagation delay skew over the recommended temperature, and input current, and power supply ranges.

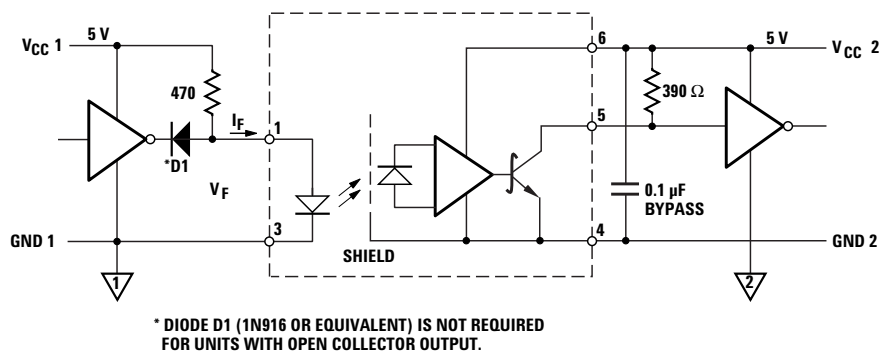


Figure 13. Recommended TTL/LSTTL to TTL/LSTTL Interface Circuit.

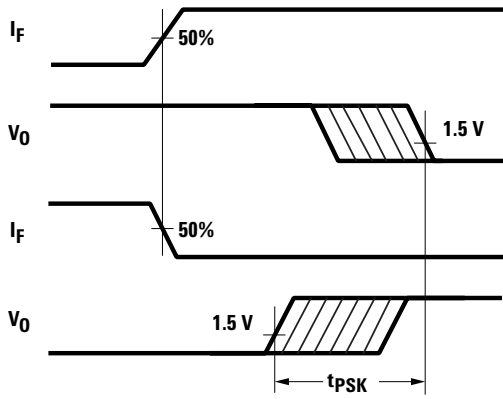


Figure 14. Illustration of Propagation Delay Skew – t_{PSK}

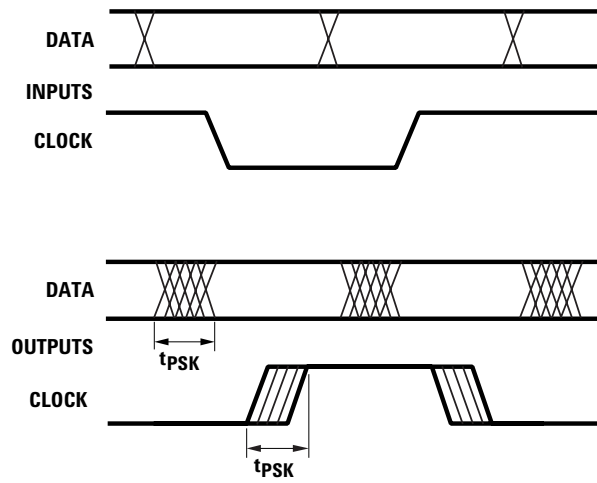


Figure 15. Parallel Data Transmission Example

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